File No.: 9-14774-13US DATE: March 30, 2004

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant:

Alexander R. LaChance et al.

Serial No.:

Not yet assigned

Filed:

Concurrently herewith.

Title:

METHOD AND APPARATUS FOR PRODUCING A 3-D

MODEL OF A SEMICONDUCTOR CHIP FROM MOSAIC

IMAGES

Agent of Record:

9-14774-13US

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Commissioner for Patents
United States Patent and Trademark Office
P.O. Box 1450
Alexandria, VA 22313-1450
U.S.A.

Sir:

INFORMATION DISCLOSURE STATEMENT PRIOR TO FIRST OFFICE ACTION

Pursuant to the duty of disclosure under 37 CFR 1.56, copies of the references listed on the attached PTO Form 1449 (other than U.S. patents and U.S. published applications) are submitted herewith.

The Examiner is kindly requested to consider these references during the examination of the above-identified application, making the references of record, and to return an initialed copy of the PTO-1449 Form to the below-signed agent.

In accordance with 37 CFR 1.97(h), the submission of the present information is not to be construed as an admission that such information is, or is considered to be material to patentability.

Respectfully submitted,

By:

Max R. Wood, Registration No.40,388

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Encls.

Sheet 1 of

Form PTO-1449	U.S. Department of Commerce	ATTY.DOCKET NO.	SERIAL NO.	
(Rev.7-80)	Patent & Trademark Office	9-14774-13US	Not yet assigned	
LIST OF REF	ERENCES CITED BY APPLICANT	APPLICANT		
(Use several sheets if necessary)		Alexander R. LaChance		
		FILING DATE:	GROUP	
		Concurrently herewith		

U.S. PATENT DOCUMENTS

*Examiner Initial		Document Number	Date	Name	Class	Subcl ass	Filing Date
	AA	2003/0084409	May 1, 2003	Abt et al.	G06F	17/50	Oct/10/02
	AB						
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A	AD						
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FOREIGN PATENT DOCUMENTS

	Document number	Date	Country	Class	Subclass	Translation
AL						
AM						
AN						
AO						
AP						

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

	Sobel Edge Detector, pages 1-10 http://www.dai.ed.ac.uk/HIPR2/sobel.htm				
AR					
AS	R2V softwares - Vectorising the raster/scanned maps with easy and fastest way, Dr. Yecheng (Ted) Wu, Pages 1-4, http://www.gisdevelopment.net/technology/gis/techgi0015pf.htm				
710					
АТ					

Examiner	Date considered			
*Examiner: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant				